



**CLE Series** 

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#### 1. SCOPE

1.1. This specification is applicable to Lead-free and Halogen-free of RoHS Directive for CLE Series Wide Terminal Metal Alloy Low-Resistance Resistor.

1.2. The product is for general electronic purpose.

#### 2. PART NUMBERING SYSTEM

Part Numbering is made in accordance with the following system:

CLE	32W	1		R003	] _	F	L	-	4
Туре	Size (mm/inch)	Power Rating	1	Nominal Resistance		Resistance Tolerance	Packaging		Number of Terminal
Metal Alloy Low Resistance Resistors	16W (0306) 21W (0508)	A=1/2 W B=1.5 W C=3/4 W 1=1 W	Resistors	Resistance (4~6 Digit) R003 = $3m\Omega$ R0005 = $0.50m\Omega$ R00075 = $0.75m\Omega$		D=±0.5% F=±1.0% G=±2.0% J=±5.0%	L=5,000 pcs		2: 2 terminals 4; 4 terminals (Leave blank if 2 terminal)

#### 3. RATING

#### 3.1. Rated Power

#### 3.1.1 Resistor Rated Power

Туре	# of Terminals	Rating Power	Rating Current	Overload Current		
CLE1CW/	2	1/2 W				
CLE16W	4	1/2 W				
CLE21W	2	3/4 W 1 W	Ir= $\sqrt{P/R}$ Ir: Rating Current (A)	$Io = \sqrt{4P/R}$ Io : Overload Current (A)		
CLE32W	2	1 W	P: Rating Power (W) R: R value(Ω)	P: Rating Power (W) R: R value(Ω)		
CLLSZVV	2	1.5 W				
CLE32W	4	1 W				
CLL32VV	4	1.5 W				

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#### 3.2 Power Derating Curve

Operating Temperature Range: - 55 ~+155 °C

For resistors operated in ambient temperatures 70°C, power rating shall be derated in accordance with the curve below:

Туре	CLE16W-4T	Others			
Temperature Range	-55°C~+155°C	-55°C~+150°C			
Description	For resistors operated in ambient temperatures 70°C~155°C, power rating shell be derated in accordance with the curve below.	For resistors operated in ambient temperatures 70°C~150°C, power rating shell be derated in accordance with the curve below.			
Power derate curve	100%	(			

#### 3.3 Standard Atmospheric Condition

Unless otherwise specified, the standard range of atmospheric conditions for making measurements and tests is as follows:

Ambient Temperature =  $+5^{\circ}$ C to  $+35^{\circ}$ C

Relative Humidity = < 85% RH

Air Pressure = 86 to 106kPa

If there may be any doubt about the results, measurement shall be made within the following limits :

Ambient Temperature =  $20\pm 2^{\circ}$ C

Relative Humidity = 60 to 70% RH

Air Pressure = 86 to 106kPa

3.4 Operating Temperature Range -55°C to +150°C

3.5 Storage Temperature Range  $-5^{\circ}$ C to  $+40^{\circ}$ C / < 85% RH

3.6 Flammability Rating Tested in accordance to UL-94, V-0

3.7 Moisture Sensitivity Level Rating: Level 1



**Product Specification** 

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- 3.8 **Product Assurance** ASJ resistor shall warranty 24 months from manufacturing date with control conditions.
- 3.9 ASJ resistors are RoHS-compliant in accordance to RoHS Directive.
- Resistance, Resistance Tolerance and Temperature Coefficient of Resistance 3.10

	н - £	Datin -		Overdend	TCD		ce Range nΩ)	Operating	
Туре	# of Terminals	Rating Power	Rating Current	Overload Current	T.C.R. (ppm/°C)	D (±0.5%)	F (±1%) G (±2%) J (±5%)	Temperature Range	
	2	1/2\\/			≦±300		1≦R<5	-55~+150°C	
CLE16W	2 1/2W	1/200			≦±100		5≦R≦10	-33 +130 C	
CLETOW	CLE16W 4 1/2W	1 /2\\			≦±150		1≦R<6	FF~:1FF°C	
		1/200			≦±50		6≦R≦10	-55~+155°C	
CLE21W	2	3/4W	Current (A)	Io=√4P/R Io: Overload Current (A) P: Rating Power (W)	≦±100		1≦R<2	-55~+150°C	
CLLZIVV	2	1W			≦±50		2≦R≦14		
		1 W			≦±100		0.5≦R≦0.75		
					≦±100		1≦R<5		
CLE32W	2				≦±50		5≦R≦25		
		1 5\\			≦±100		1≦R<5		
		1 .5W			≦±50		5≦R≦10		
			1		≦±200		0.75		
CI E33344	4	1 W			≦±75		1≦R<5		
CLE32W	4				≦±50		5≦R≦15		
		1.5W			≦±75		1≦R≦5		

#### 3.11 **Rated Current**

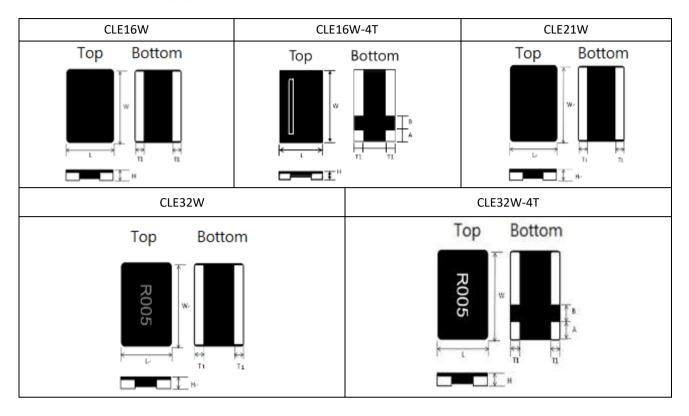
The resistor shall have a DC continuous working current or a RMS(Root Mean Square). AC continuous working current at commercial-line frequency and wave form corresponding to the power rating, as determined from the following:



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#### 4. DIMENSION



	Maximum Power	Resistance			Dimensions - in i	nches (millimeter	rs)	
Туре	Rating (Watts)	Range (mΩ)	L	W	Н	T1	Α	В
CLE16W	1/2	1~10	0.033±0.004 (0.85±0.10)	0.063±0.004 (1.60±0.10)	0.014±0.004 (0.35±0.10)	0.008±0.004 (0.20±0.10)		
CLE16W- 4T	1/2	1~10	0.033±0.004 (0.85±0.10)	0.063±0.004 (1.60±0.10)	0.014±0.004 (0.35±0.10)	0.008±0.004 (0.20±0.10)	0.012±0.004 (0.30±0.1)	0.012±0.004 (0.30±0.1)
CLE21W	3/4 1	1 ~14	0.05±0.008 (1.270±0.20)	0.08±0.008 (2.032±0.20)	0.014±0.004 (0.35±0.10)	0.014±0.006 (0.35±0.15)		
CLESSIA	1	0.5~0.75 1~25	0.063±0.008 (1.60±0.20)	0.126±0.008 (3.20±0.20)	0.014±0.004 (0.35±0.10)	0.014±0.006 (0.35±0.15)		
CLE32W	1.5	1~10	0.063±0.008 (1.60±0.20)	0.126±0.008 (3.20±0.20)	0.014±0.004 (0.35±0.10)	0.014±0.006 (0.35±0.15)		
CLE32W-	1	0.75 1~15	0.063±0.008 (1.60±0.20)	0.126±0.008 (3.20±0.20)	0.014±0.004 (0.35±0.10)	0.016±0.006 (0.40±0.15)	0.020±0.006 (0.50±0.15)	0.020±0.006 (0.50±0.15)
4T	1.5	1~5	0.063±0.008 (1.60±0.20)	0.126±0.008 (3.20±0.20)	0.014±0.004 (0.35±0.10)	0.016±0.006 (0.40±0.15)	0.020±0.006 (0.50±0.15)	0.020±0.006 (0.50±0.15)

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## 4.1 Material of Alloy

Туре	Watts	Material	Resistance	
CL E4 CVV	1/214/	Copper-Manganese Alloy	$1m\Omega \leq R \leq 4m\Omega$	
CLE16W	1/2W	Iron-Chromium Aluminium Alloy	$5m\Omega \le R \le 10m\Omega$	
CLEACIN AT	4/204	Copper-Manganese Alloy	$1m\Omega \le R \le 5m\Omega$	
CLE16W-4T	1/2W	Iron-Chromium Aluminium Alloy	$6m\Omega \le R \le 10m\Omega$	
CLEDANA	CLE21W 3/4W 1W	Copper-Manganese Alloy	$1m\Omega \le R \le 4m\Omega$	
CLEZIW		Iron-Chromium Aluminium Alloy	5mΩ ≤ R ≤ 14mΩ	
	1W	Copper-Manganese Alloy	$0.5 \text{m}\Omega \le R \le 4 \text{m}\Omega$	
CLF32W		Iron-Chromium Aluminium Alloy	5mΩ ≤ R ≤ 25mΩ	
CLE32VV	1 5\4/	Copper-Manganese Alloy	$1m\Omega \le R \le 4m\Omega$	
	1.5W	Iron-Chromium Aluminium Alloy	5mΩ ≤ R ≤ 10mΩ	
	414/	Copper-Manganese Alloy	$0.75 \text{m}\Omega \leq R \leq 4 \text{m}\Omega$	
CLF32W-4T	1W	Iron-Chromium Aluminium Alloy	5mΩ ≤ R ≤ 15mΩ	
CLE32VV-41	1 5\4/	Copper-Manganese Alloy	$1m\Omega \le R \le 4m\Omega$	
	1.5W	Iron-Chromium Aluminium Alloy	5mΩ	

### 4.2 Plating Thickness:

 $4.2.1~Ni:\,\geq 2~\mu m$ 

4.2.2 Sn (Tin) :  $\geq$  3  $\mu m$ 

4.2.3 Sn (Tin): Matte Sn

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#### 5. MARKING FORMAT

- 5.1 CLE16W, CLE21W No Marking
- 5.2 CLE16W-4T Marking is rectangle and by laser.

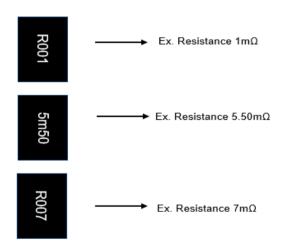


### 5.3 CLE32W, CLE32W-4T:

Product resistance is indicated by using two marking notation styles:

- a. "R" designated the decimal location in ohms, e.g.
  - For 1mΩ the product marking is R001;
  - For 7mΩ the product marking is R007;
- b. "m" designated the decimal location in milliohm, e.g.
  - For  $0.25m\Omega$  the product marking is 0m25;
  - For 0.5mΩ the product marking is 0m50;
  - For 5.5mΩ the product marking is 5m50

#### 5.4 CLE32W



#### 5.5 CLE32W-4Terminal



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# 5.6 Marking styles by Laser: (For CLE32W and CLE32W-4Terminal)

Type Marking	R	m	1	2	3	4	5	6	7	8	9	0
CLE32W CLE32W-4T					(ZZ)		CM	60	7		(C)	

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#### 6. RELIABILITY PERFORMANCE

#### 6.1 Electrical Performance Test

Test Item		Со	nditions o	f Test	Test Limits
Temperature Coefficient of Resistance (TCR)	TCR(ppm)  ■ R1: re ■ R2: re ■ T1: Ro	$f(S) = \frac{(R2 - R)}{R1(T2 - R)}$ sistance of rootsistance of 150 to m temperature at 1	R1) · T1) x10 <sup>6</sup> m temper · °C re	ature	Refer to Paragraph 3.10
Short Time Overload	Refer to J Applied O about 30	IS C 5201-1 4.8 verload for 5 s	econds an measure it	d release the load for as resistance variance rate.  y):  # of rated power  4 times  4 times	CLE16W-4T/CLE32W: ≦±1.0% Others: ≦±0.5% No evidence of mechanical damage
Insulation Resistance Dielectric	Put the re 60secs the electrode and base	IS-C5201-1 4.6 sistor in the fixen measured the sand insulating material.	kture, add ne insulati g enclosur	≧10 <sup>8</sup> Ω	
Withstanding Voltage	_			Limit surge current 50 mA	No short or burned on the appearance.

### 6.2 Mechanical Performance Test

Test Item	Conditions of Test	Test Limits
	Refer to JIS-C5201-1 4.18	≦±0.5%
Resistance to	The tested resistor be immersed 25 mm/sec into molten	No evidence of mechanical damage
Solder Heat	solder of 260±5°C for 10±1secs. Then the resistor is left in the	-
	room for 1 hour, and measured its resistance variance rate.	
	Refer to JIS-C5201-1 4.17	
Solderability	Add flux into tested resistors, immersion into solder bath in	Solder coverage over 95%
	temperature 245±5°C for 3±0.5secs.	
	Refer to JIS-C5201-1 4.22	≦±0.5%
		No evidence of mechanical damage
	supporting terminals on the solid table. The entire frequency	
Vibration	range :from 10 Hz to 55 Hz and return to 10 Hz, shall be	
	transferred in 1 min. Amplitude : 1.5mm	
	This motion shall be applied for a period of 4 hours in each 3	
	mutually perpendicular directions (a total of 12hrs)	
	Refer to JIS-C5201-1 4.29	≦±0.5%
Resistance to		No evidence of mechanical damage
solvent	20~25°C for 60secs, then the resistor is left in the room for	
	48 hrs.	

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### 6.3 Environmental Performance

Test Item	Conditions of Test	Test Limits
Low Temperature Exposure (Storage)	Refer to JIS-C5201-1 4.23.4 Put the tested resistor in chamber under temperature - 55±2°C for 1,000 hours. Then leaving the tested resistor in room temperature for 60 minutes, and measure its resistance variance rate.	≦±0.5%  No evidence of mechanical damage
High Temperature Exposure (Storage)	Refer to JIS-C5201-1 4.23.2  Put tested resistor in chamber under temperature  150±5°C (CLE16W-4T 155±5°C) for 1,000 hours. Then leaving the tested resistor in room temperature for 60 minutes, and measure its resistance variance rate.	≦±1.0%  No evidence of mechanical damage
Temperature Cycling (Rapid Temperature Change)	Refer to JIS-C5201-1 4.19  Put the tested resistor in the chamber under the temperature cycling which shown in the following table shall be repeated 300 times consecutively. Then leaving the tested resistor in the room temperature for 60 minutes, and measure its resistance variance rate.  Testing Condition  Lowest Temperature  -55 +0/-10°C  Highest Temperature  150 +10/-0°C	≦±1.0%  No evidence of mechanical damage
Moisture Resistance (Climatic Sequence)	Refer to MIL-STD 202 Method 106 Put the tested resistor in chamber and subject to 10 cycles of damp heat and without power. Each one of which consists of the steps 1 to 7 (Figure 1). Then leaving the tested resistor in room temperature for 24 hr, and measure its resistance variance rate.	≦±0.5%  No evidence of mechanical damage
Bias Humidity	Refer to JIS-C5201-1 4.24  Put the tested resistor in chamber under 85± 5°Cand 85± 5%RH with 10% bias and load the rated voltage for 90 minutes on, 30 minutes off, total 1,000 hours. Then leaving the tested resistor in room temperature for 60 minutes, and measure its resistance variance rate.	≦±1.0%  No evidence of mechanical damage

## 6.4 Operational life Endurance

Test Item	Conditions of Test	Test Limits
	Put the tested resistor in chamber under temperature 70±	≦±1.0%
Load Life	2°C and load the rated voltage for 90 minutes on 30 minutes off, total 1000 hours. Then leaving the tested resistor in room temperature for 60 minutes, and measure its resistance variance rate.  Refer to JIS-C5201-1 4.25	No evidence of mechanical damage

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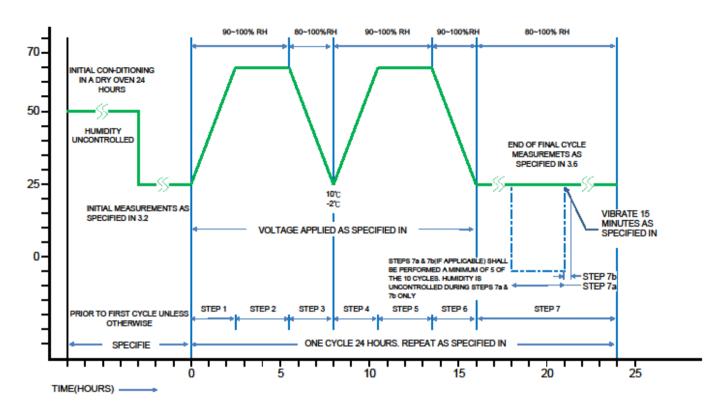
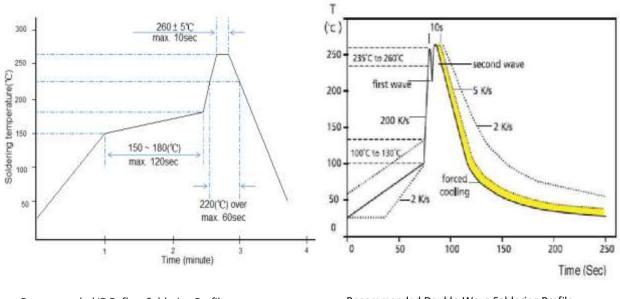


Figure 1

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- 6.5 Recommended Soldering Method
  Technical application notes: This is for recommendation, customer please perform adjustment according to actual application.
  - 6.5.2 This product is applicable to IR-reflow process only.(Infrared Reflow)
- 6.5.3 Surface-mount components are tested for solderability at a temperature of 245 °C for 3 seconds
- 6.5.4 Typical examples of soldering processes that provides reliable joints without any damage are given below:



Recommended IR Reflow Soldering Profile MEET J-STD-020D

Recommended Double-Wave Soldering Profile Typical values (solid line) Process limits (dotted line)

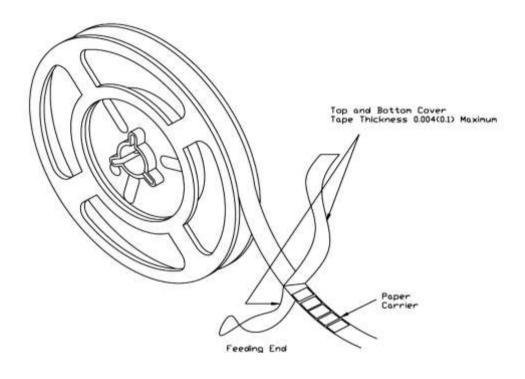
6.5.4 Soldering Iron: temperature  $350^{\circ}\text{C} \pm 10^{\circ}\text{C}$ , dwell time shall be less than 3 sec.

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### 7. TAPING

### 7.1 Structure of Taping

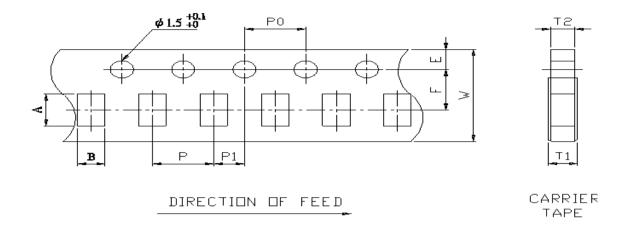
Paper Carrier



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## 7.2 Tape Dimension



Unit: mm

DIM	А	В	W	E	F	T1	T2	Р	P0	10*P0	P1
CLE16W	1.80±0.10	1.00±0.10	8.0±0.20	1.75±0.10	3.5±0.05	$0.40^{+0.2}_{-0}$	0.40±0.10	4.0±0.10	4.0±0.10	40.0±0.20	2.0±0.05
CLE16W-4T	1.80±0.10	1.00±0.10	8.0±0.20	1.75±0.10	3.5±0.05	$0.40^{+0.2}_{-0}$	0.40±0.10	4.0±0.10	4.0±0.10	40.0±0.20	2.0±0.05
CLE21W	2.30±0.10	1.55±0.10	8.0±0.20	1.75±0.10	3.5±0.05	$0.40^{+0.2}_{-0}$	0.40±0.05	4.0±0.10	4.0±0.10	40.0±0.20	2.0±0.05
CLE32W	3.50±0.20	1.90±0.20	8.0±0.20	1.75±0.10	3.5±0.05	$0.60^{+0.2}_{-0}$	0.60±0.05	4.0±0.10	4.0±0.10	40.0±0.20	2.0±0.05
CLE32W-4T	3.50±0.20	1.90±0.20	8.0±0.20	1.75±0.10	3.5±0.05	$0.60^{+0.2}_{-0}$	0.60±0.05	4.0±0.10	4.0±0.10	40.0±0.20	2.0±0.05

## 7.3 Packaging

## 7.3.1 Taping

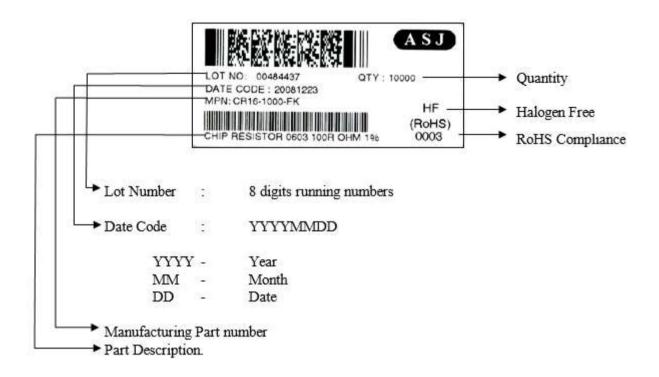
## Quantity – Tape and Reels

Tuno	# of terminal	nal Tape width	Max. Packaging Quantity (pcs/reel)		
Type	# Of terminal		4 mm pitch		
CLE16W	2	8 mm	5,000pcs		
CLE16W	4	8 mm	5,000pcs		
CLE21W	2	8 mm	5,000pcs		
CLE32W	2	8 mm	5,000pcs		
CLE32W	4	8 mm	5.000pcs		

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#### 7.3.2 Identification

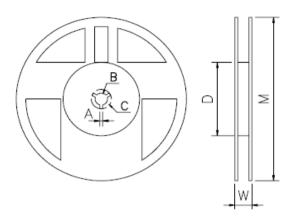
Production label that indicates the 8 digits lot number, product type, resistance value and tolerance shall be pasted on the surface of each reel.



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### 7.3.3 Reel Dimension



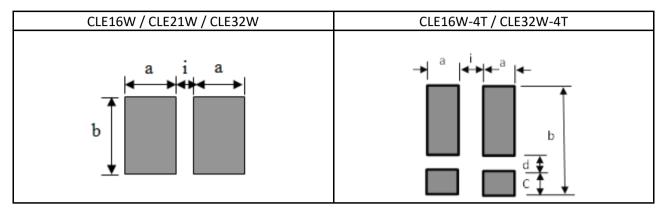
(Unit: mm)

Reel Type/ Tape	W	M	Α	В	С	D
7" reel for 8 mm tape	12.0 ± 0.5	178 ± 1.0	2.0 ± 0.5	13.2 ± 0.5	17.7 ± 0.5	60.0 ± 1.0

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#### 8. RECOMMENDED LAND PATTERN

When a component is soldered, the resistance after soldering changes slightly depending on the size of the soldering area and the amount of soldering. When designing a circuit, it is necessary to consider the effect of a decrease or increase in its resistance.



_	Maximum	Resistance	Dimensions (millimeters)				
Type	Power Rating (Watts)	Range (mΩ)	а	b	С	d	i
CLE16W	1/2	1~10	0.40	1.80			0.40
CLE16W-4T	1/2	1~10	0.50	1.90	0.40	0.25	0.20
CLE21W	3/4,1	1 ~ 14	1.45	2.20			0.50
CLE32W	1, 1.5	0.5 ~ 25	1.00	3.50			0.50
CLE32W-4T	1	0.75 ~ 15	1.00	3.50	0.80	0.40	0.50

#### 9. MEASUREMENT POINT

Bottom e	Unit : mm			
2Т	<b>4</b> T	TYPE DIM	Α	В
		CLE16W	0.63±0.05	0.33±0.05
		CLE16W-4T	0.65±0.05	0.95±0.05
^	^		0.90±0.05	0.46±0.05
Current Terminal     Current Terminal     Welture Terminal		CLE32W	1.20±0.05	0.46±0.05
(c) Voltage Terminal		CLE32W-4T	1.20±0.05	1.78±0.05

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#### 10. REVISION HISTORY

REVISION	DATE	CHANGE NOTIFICATION	DESCRIPTION
Version.1	13.2.2018		Initial Release
Version.2	14.01.2019		Update datasheet
Version.3	01.10.2019		Add clause 6.3.1 Operational life
			Endurance
Version.4	05.10.2020		Revise clause 3.1.1 Resistor rated power
			Revise clause 3.5 storage temp. range
			Revise clause 3.9
			Revise clause 3.10 TCR table
			Revise clause 4 dimension
			Revise clause 6.1 item short time overload
			Revise clause 7.2 tape dimension
			Revise clause 8 Land pattern dimension
			Revise clause 9 measurement point
			dimension
Version.5	06.04.2021		Delete CLE16W-4T information
			Revise clause 2 Part Numbering System
			Revise clause 3.1.1 Resistor Rated Power
			Revise clause 3.10 TCR table
			Revise clause 4 Dimension
			Add clause 4.1 Material of Alloy
			Delete clause 5.0.2 CLE16W 4 terminal
			marking information
			Revise clause 6.1 item Short time
			Overload
			Revise clause 7.2 tape dimension
			Revise clause 7.3.1.1 Tape and reel
			Revise clause 8 Recommend Land Pattern
			Revise clause 9 Measurement Point
Version.6	18.01.2022		Revise clause 3.10 TCR table
			Revise clause 4 dimension
			Revise clause 4.1 material of alloy
			Revise clause 8 Land pattern
Version 7	20.6.2023		Add CLE21W 1W resistance range
			1~14mR, CLE32W 1.5W 1mR≤R≤2mR,
			3mR≤R≤4mR, 5mR≤R≤6mR, 7mR≤R≤10mR
			resistance, and CLE32W 1W 0.50mR &
			0.75mR resistance
			Revise clause 3.1.1 Resistor Rated Power
			Revise clause 3.8 Product Assurance
			Revise clause 3.10 table
			Revise clause 4 table
			Revise clause 4.1 table
			Revise clause 6.1 Test Item Short Time
			Overload
			Revise clause 8 table

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REVISION	DATE	CHANGE NOTIFICATION	DESCRIPTION
Version 8	26.12.2023		Revise clause 3.1.1 Resistor Rated Power
			table.
			Revise clause 3.2 Power Derating Curve
			table.
			Revise clause 3.10 table.
			Revise clause 4 Dimension table.
			Revise clause 4.1 Material of Alloy table.
			Add clause 5.2 for CLE16W-4T type.
			Revise clause 6.1 Test Item Short Time
			Overload.
			Revise clause 6.3 Test Item High
			Temperature Exposure (Storage).
			Revise clause 7.2 Tape Dimension table.
			Revise clause 7.3.1 Taping table.
			Revise clause 8 Recommended Land
			Pattern table.
			Revise clause 9 Measurement Point table.